

DESCRIPTION

The M5M5V208AKV is low voltage 2-Mbit static RAMs organized as 262,144-words by 8-bit, fabricated by high-performance 0.25μm CMOS technology.

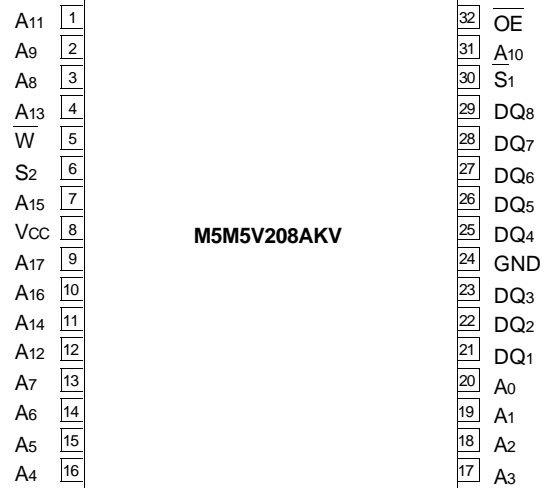
The M5M5V208AKV is suitable for memory applications where a simple interfacing, battery operating and battery backup are the important design objectives.

The M5M5V208AKV is packaged in 32-pin 8mm x 13.4mm sTSSOP packages which is a high reliability and high density surface mount device.

FEATURES

Type name	Access time (max)	Power supply current	
		Active (max)	stand-by (max)
M5M5V208AKV-55HI	55ns	35mA (10MHz)	30μA (V _{CC} =3.6V)
M5M5V208AKV-70HI	70ns	7mA (1MHz)	0.3μA (V _{CC} =3.0V TYPICAL)

PIN CONFIGURATION (TOP VIEW)



Outline 32P3K-B(KV)

- Single 2.7 ~3.6V power supply
- No clock, No refresh
- Directly TTL compatible : All inputs and outputs
- Easy memory expansion and power down by S1,S2
- Data hold on +2V power supply
- Three-state outputs : OR - tie capability
- OE prevents data contention in the I/O bus
- Common data I/O
- Package
M5M5V208AKV 32pin 8 X 13.4 mm² sTSSOP

FUNCTION

The operation mode of the M5M5V208AKV series are determined by a combination of the device control inputs $\overline{S_1}$, S_2 , \overline{W} and \overline{OE} .

Each mode is summarized in the function table.

A write cycle is executed whenever the low level \overline{W} overlaps with the low level $\overline{S_1}$ and the high level S_2 . The address must be set up before the write cycle and must be stable during the entire cycle. The data is latched into a cell on the trailing edge of \overline{W} , $\overline{S_1}$ or S_2 , whichever occurs first, requiring the set-up and hold time relative to these edge to be maintained. The output enable input \overline{OE} directly controls the output stage. Setting the \overline{OE} at a high level, the output stage is in a high-impedance state, and the data bus contention problem in the write cycle is eliminated.

A read cycle is executed by setting \overline{W} at a high level and \overline{OE} at a low level while $\overline{S_1}$ and S_2 are in an active state ($\overline{S_1}=L, S_2=H$).

When setting $\overline{S_1}$ at a high level or S_2 at a low level, the chip are in a non-selectable mode in which both reading and writing are disabled. In this mode, the output stage is in a high-impedance state, allowing OR-tie with other chips and memory expansion by $\overline{S_1}$ and S_2 . The power supply current is reduced as low as the stand-by current which is specified as I_{CC3} or I_{CC4} , and the memory data can be held at +2V power supply, enabling battery back-up operation during power failure or power-down operation in the non-selected mode.

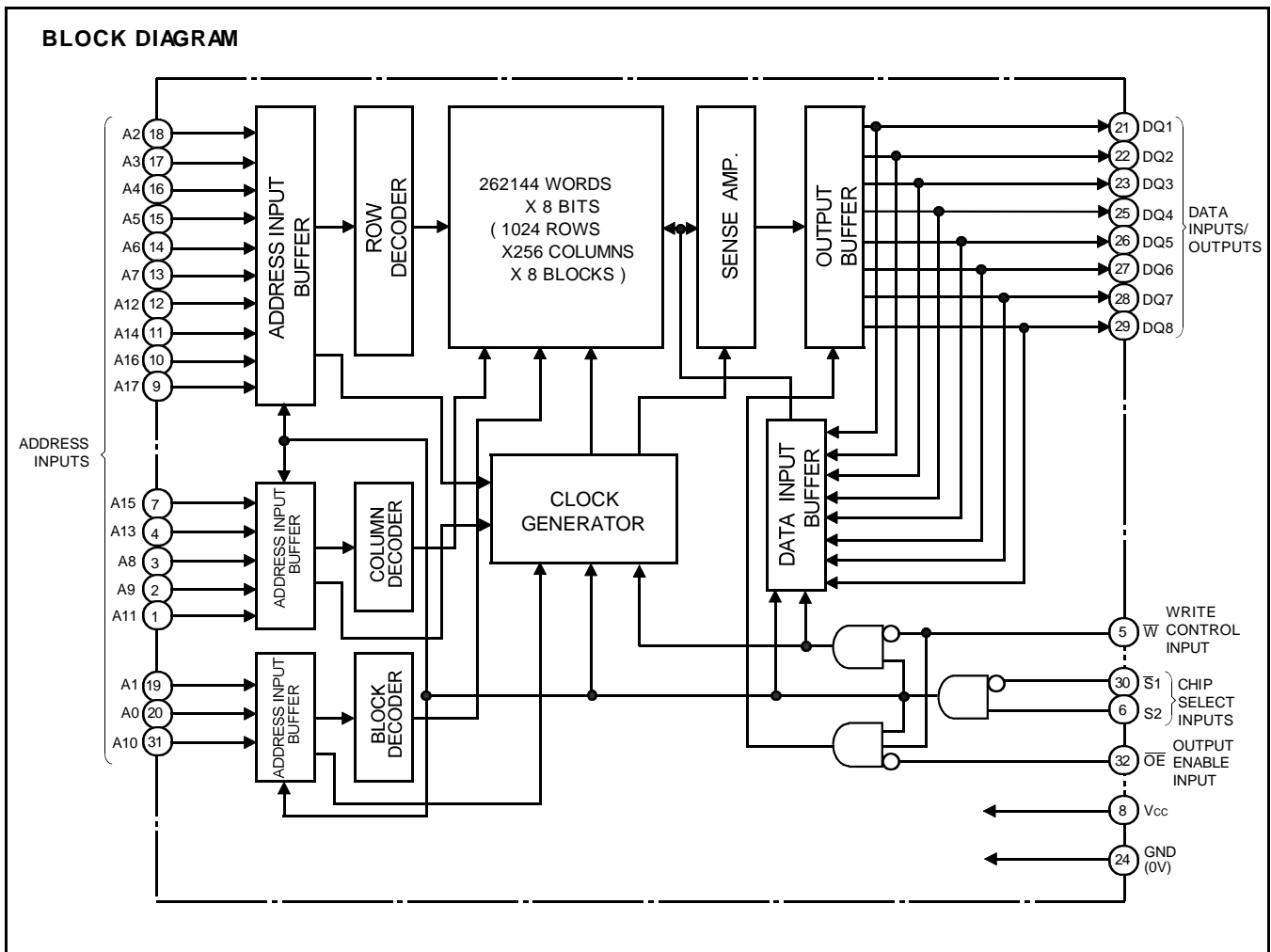
FUNCTION TABLE

$\overline{S_1}$	S_2	\overline{W}	\overline{OE}	Mode	DQ	I _{CC}
X	L	X	X	Non selection	High-impedance	Stand-by
H	X	X	X	Non selection	High-impedance	Stand-by
L	H	L	X	Write	Din	Active
L	H	H	L	Read	Dout	Active
L	H	H	H	—	High-impedance	Active

Note 1: "H" and "L" in this table mean V_{IH} and V_{IL}, respectively.

2: "X" in this table should be "H" or "L".

BLOCK DIAGRAM



ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Conditions	Ratings	Unit
V _{CC}	Supply voltage	With respect to GND	- 0.5*~4.6	V
V _I	Input voltage		- 0.5*~V _{CC} + 0.3	V
V _O	Output voltage		0~V _{CC}	V
P _d	Power dissipation	T _a =25°C	700	mW
T _{opr}	Operating temperature		- 40~85	°C
T _{stg}	Storage temperature		- 65~150	°C

* -3.0V in case of AC (Pulse width ≤ 30ns)

DC ELECTRICAL CHARACTERISTICS (T_a= -40~85°C, V_{CC}=2.7~3.6V, unless otherwise noted)

Symbol	Parameter	Test conditions	Limits			Unit
			Min	Typ	Max	
V _{IH}	High-level input voltage		2.0		V _{CC} + 0.3	V
V _{IL}	Low-level input voltage		-0.3*		0.6	V
V _{OH1}	High-level output voltage 1	I _{OH} = - 0.5mA	2.4			V
V _{OH2}	High-level output voltage 2	I _{OH} = - 0.05mA	V _{CC} - 0.5			V
V _{OL}	Low-level output voltage	I _{OL} = 2mA			0.4	V
I _I	Input current	V _I =0~V _{CC}			±1	μA
I _O	Output current in off-state	$\overline{S_1}=V_{IH}$ or $S_2=V_{IL}$ or $\overline{OE}=V_{IH}$ V _{I/O} =0~V _{CC}			±1	μA
I _{CC1}	Active supply current (CMOS-level input)	S ₁ ≤ 0.2V, S ₂ ≥ V _{CC} -0.2V other inputs ≤ 0.2V or ≥ V _{CC} -0.2V, Output-open	10MHz	28	30	mA
			1MHz	5	7	
I _{CC2}	Active supply current (TTL-level input)	S ₁ =V _{IL} , S ₂ =V _{IH} , other inputs=V _{IH} or V _{IL} , Output-open	10MHz	33	35	mA
			1MHz	5	7	
I _{CC3}	Stand-by current	1) S ₂ ≤ 0.2V, other inputs=0 ~ V _{CC} 2) S ₁ ≥ V _{CC} - 0.2V, S ₂ ≥ V _{CC} - 0.2V other inputs=0 ~ V _{CC}	~25°C	0.3	2	μA
			~40°C		5	
			~70°C		10	
			~85°C		30	
I _{CC4}	Stand-by current	1) $\overline{S_1}=V_{IH}$, other inputs=V _{IL} or V _{IH} 2) S ₂ =V _{IL} , other inputs=V _{IL} or V _{IH}			0.33	mA

* -3.0V in case of AC (Pulse width ≤ 30ns)

CAPACITANCE (T_a= -40~85°C, unless otherwise noted)

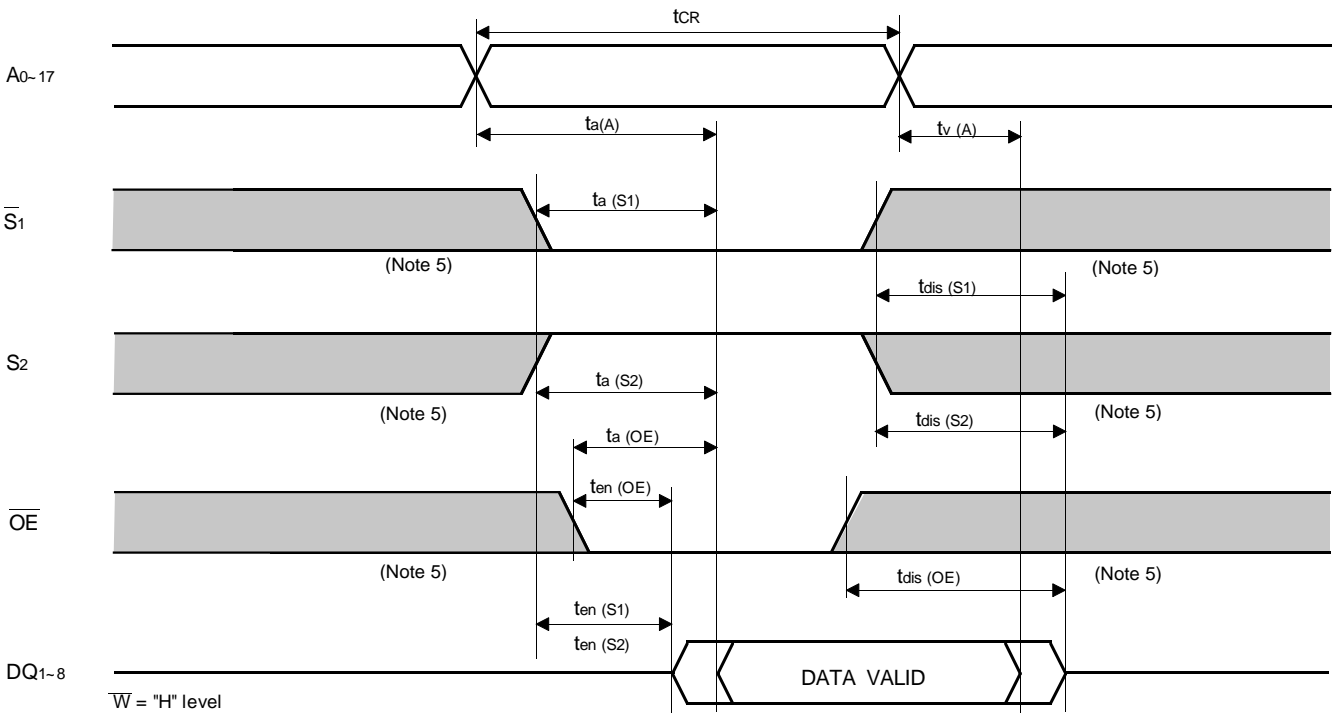
Symbol	Parameter	Test conditions	Limits			Unit
			Min	Typ	Max	
C _I	Input capacitance	V _I =GND, V _I =25mVrms, f=1MHz			8	pF
C _O	Output capacitance	V _O =GND, V _O =25mVrms, f=1MHz			10	pF

Note 3: Direction for current flowing into an IC is positive (no mark).

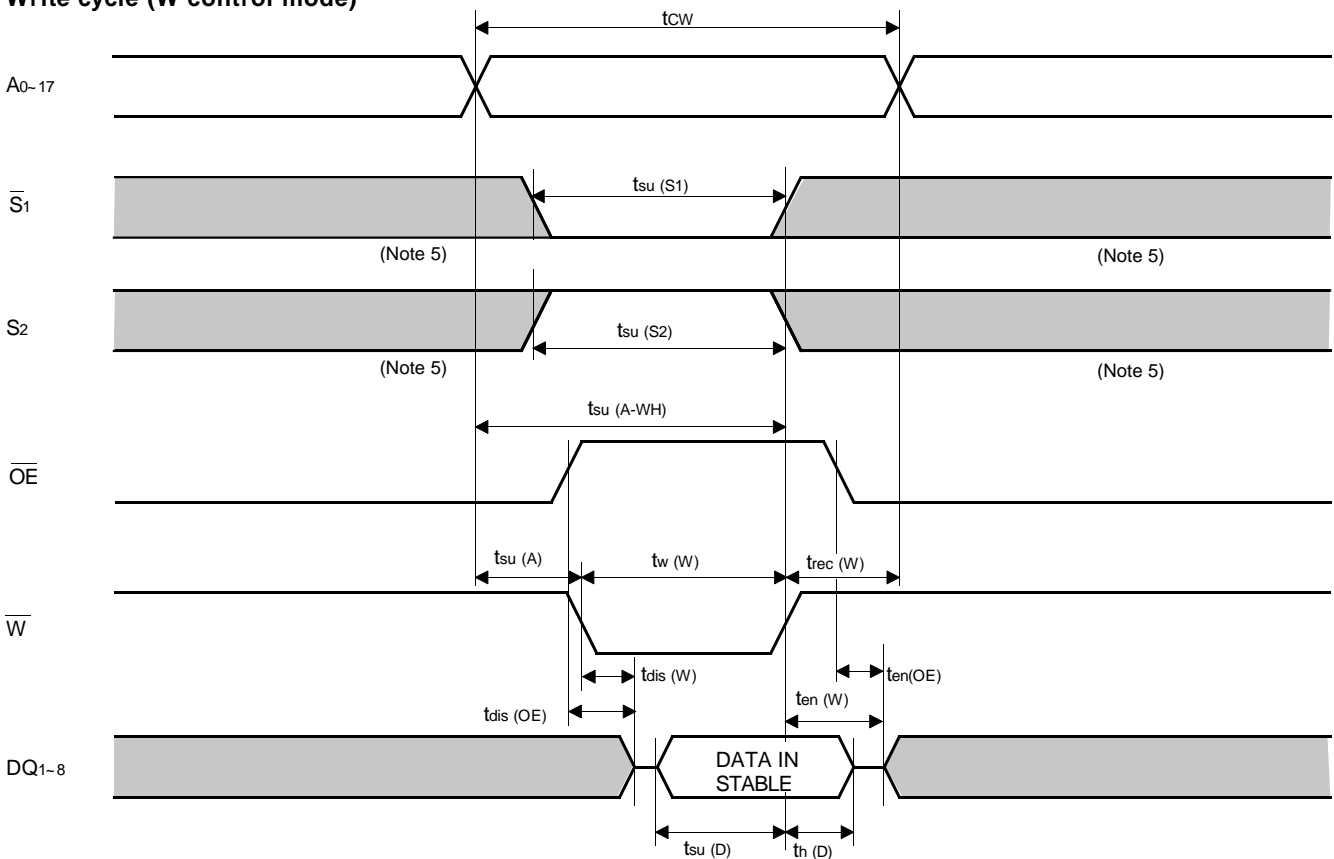
4: Typical value is V_{CC} = 3V, T_a = 25°C

(4) TIMING DIAGRAMS

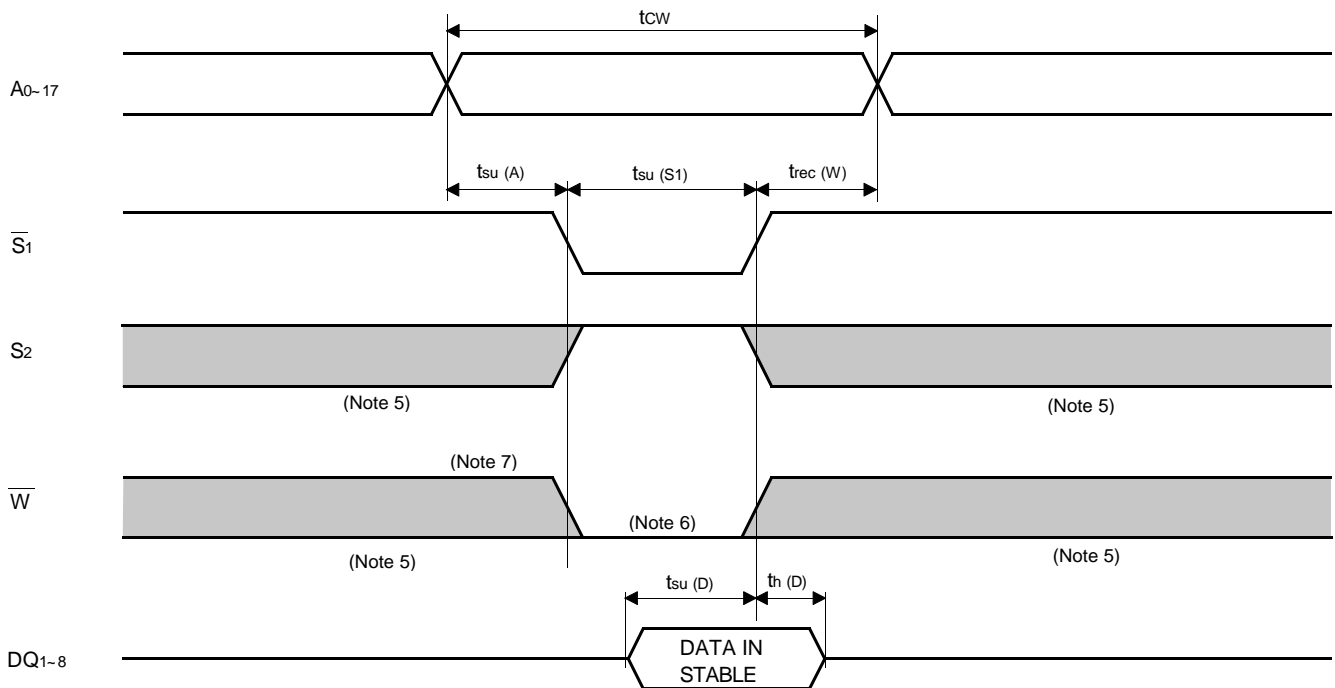
Read cycle



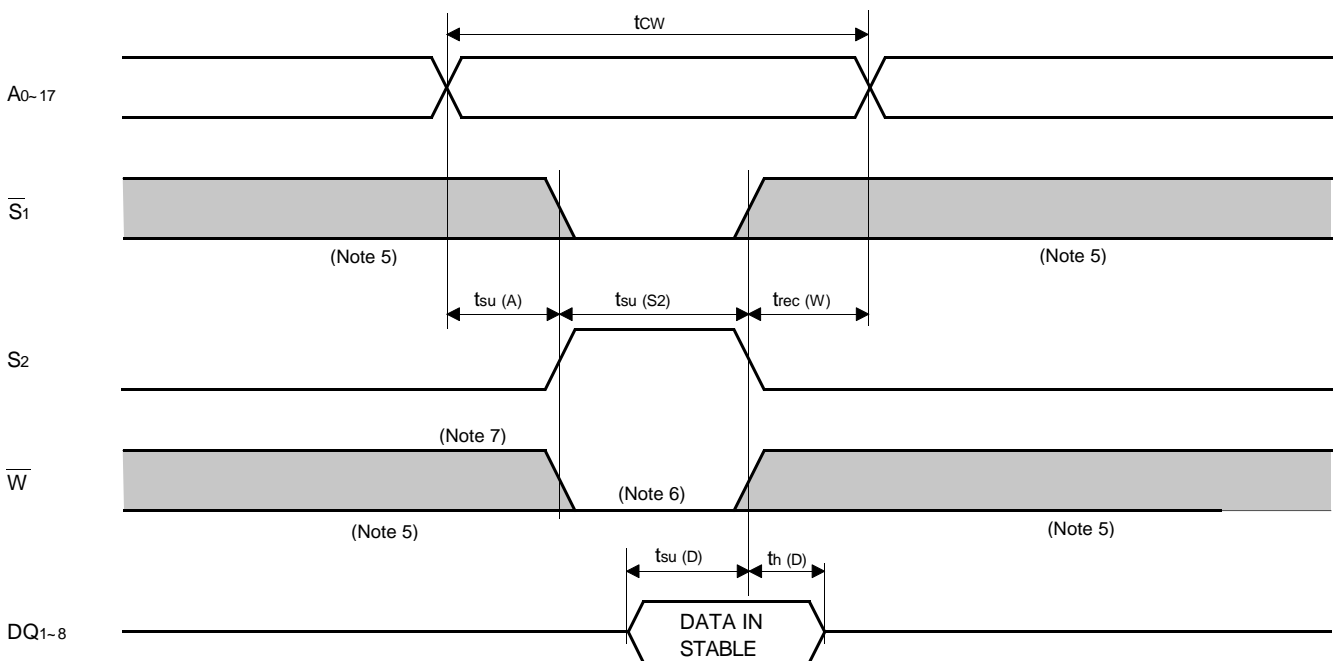
Write cycle (\overline{W} control mode)



Write cycle ($\overline{S1}$ control mode)



Write cycle (S2 control mode)



- Note 5: Hatching indicates the state is "don't care".
 6: Writing is executed while S2 high overlaps $\overline{S1}$ and \overline{W} low.
 7: When the falling edge of \overline{W} is simultaneously or prior to the falling edge of $\overline{S1}$ or rising edge of S2, the outputs are maintained in the high impedance state.
 8: Don't apply inverted phase signal externally when DQ pin is output mode.

POWER DOWN CHARACTERISTICS

(1) ELECTRICAL CHARACTERISTICS (T_a= -40~85°C, unless otherwise noted)

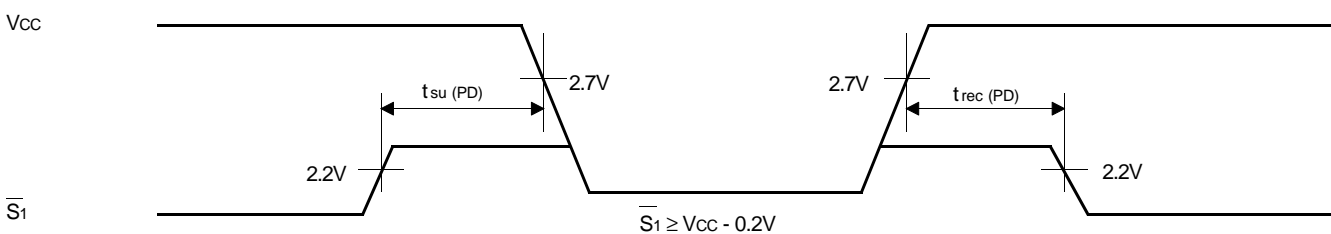
Symbol	Parameter	Test conditions	Limits			Unit
			Min	Typ	Max	
V _{CC} (PD)	Power down supply voltage		2.0			V
V _I (S1)	Chip select input $\overline{S1}$		2.0			V
V _I (S2)	Chip select input S2				0.2	V
I _{CC} (PD)	Power down supply current	V _{CC} = 3.0V 1) S ₂ ≤ 0.2V, other inputs = 0~V _{CC} 2) $\overline{S1} \geq V_{CC}-0.2V$, S ₂ ≥ V _{CC} -0.2V, other inputs = 0~V _{CC}	~25°C	0.3	1	μA
			~40°C		3	
			~70°C		8	
			~85°C		24	

(2) TIMING REQUIREMENTS (T_a=-40~85°C, unless otherwise noted)

Symbol	Parameter	Test conditions	Limits			Unit
			Min	Typ	Max	
t _{su} (PD)	Power down set up time		0			ns
t _{rec} (PD)	Power down recovery time		5			ms

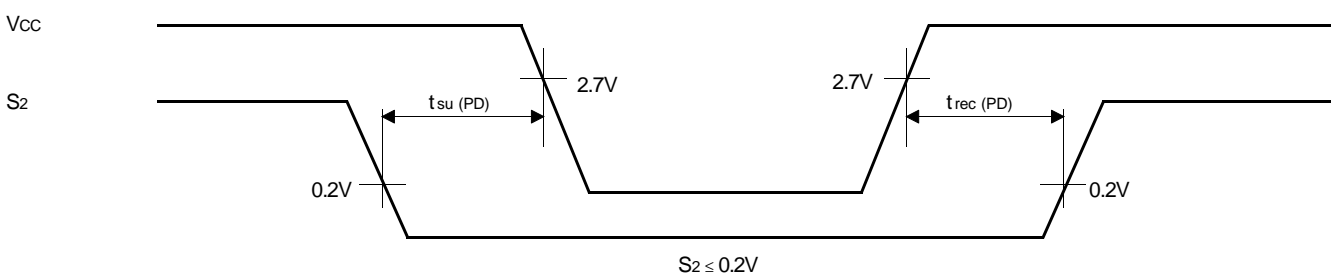
(3) POWER DOWN CHARACTERISTICS

$\overline{S1}$ control mode



Note 9: On the power down mode by controlling $\overline{S1}$, the input level of S2 must be S₂ ≥ V_{CC} - 0.2V or S₂ ≤ 0.2V. The other pins(Address, I/O, \overline{WE} , \overline{OE}) can be in high impedance state.

S2 control mode



Renesas Technology Corp.

Nippon Bldg.,6-2,Otemachi 2-chome,Chiyoda-ku,Tokyo,100-0004 Japan

Keep safety first in your circuit designs!

- Renesas Technology Corporation puts the maximum effort into making semiconductor products better and more reliable, but there is always the possibility that trouble may occur with them. Trouble with semiconductors may lead to personal injury, fire or property damage. Remember to give due consideration to safety when making your circuit designs, with appropriate measures such as (i) placement of substitutive, auxiliary circuits, (ii) use of nonflammable material or (iii) prevention against any malfunction or mishap.

Notes regarding these materials

- These materials are intended as a reference to assist our customers in the selection of the Renesas Technology Corporation product best suited to the customer's application; they do not convey any license under any intellectual property rights, or any other rights, belonging to Renesas Technology Corporation or a third party.
- Renesas Technology Corporation assumes no responsibility for any damage, or infringement of any third-party's rights, originating in the use of any product data, diagrams, charts, programs, algorithms, or circuit application examples contained in these materials.
- All information contained in these materials, including product data, diagrams, charts, programs and algorithms represents information on products at the time of publication of these materials, and are subject to change by Renesas Technology Corporation without notice due to product improvements or other reasons. It is therefore recommended that customers contact Renesas Technology Corporation or an authorized Renesas Technology Corporation product distributor for the latest product information before purchasing a product listed herein. The information described here may contain technical inaccuracies or typographical errors. Renesas Technology Corporation assumes no responsibility for any damage, liability, or other loss rising from these inaccuracies or errors. Please also pay attention to information published by Renesas Technology Corporation by various means, including the Renesas Technology Corporation Semiconductor home page (<http://www.renesas.com>).
- When using any or all of the information contained in these materials, including product data, diagrams, charts, programs, and algorithms, please be sure to evaluate all information as a total system before making a final decision on the applicability of the information and products. Renesas Technology Corporation assumes no responsibility for any damage, liability or other loss resulting from the information contained herein.
- Renesas Technology Corporation semiconductors are not designed or manufactured for use in a device or system that is used under circumstances in which human life is potentially at stake. Please contact Renesas Technology Corporation or an authorized Renesas Technology Corporation product distributor when considering the use of a product contained herein for any specific purposes, such as apparatus or systems for transportation, vehicular, medical, aerospace, nuclear, or undersea repeater use.
- The prior written approval of Renesas Technology Corporation is necessary to reprint or reproduce in whole or in part these materials.
- If these products or technologies are subject to the Japanese export control restrictions, they must be exported under a license from the Japanese government and cannot be imported into a country other than the approved destination. Any diversion or reexport contrary to the export control laws and regulations of Japan and/or the country of destination is prohibited.
- Please contact Renesas Technology Corporation for further details on these materials or the products contained therein.